00085 REVISIONS 6949001 DATE APPROVAL DESCRIPTION REPLACES REV G WITH CHANGES AND UPGRADED TO CLASS A RELEASE PER TDRR 02823 REQUIREMENTS: (3) SEAL TEST: THE UNITS SHALL BE SUBJECTED TO A HELUIM OR GENERAL: RADIFLO LEAK DETECTION TEST WITH A SENSITIVITY OF AT LEAST A. INTERPRET DRAWING IN ACCORDANCE WITH STANDARDS PRESCRIBED BY 1 X 10-6 CUBIC CENTIMETERS PER ATMOSPHERE PER SECOND. LEAKAGE RATE OF THIS VALUE OR GREATER SHALL CONSTITUTE MIL-D-70327. A FAILURE. THIS TEST SHALL BE PERFORMED ON A 100-PERCENT-B. UNITS SHALL MEET THE REQUIREMENTS OF MIL-S-19500 WITH THE MODI-OF-A-LOT BASIS. FICATIONS AND ADDITIONS SPECIFIED HEREIN. (4) VISUAL AND MECHANICAL EXAMINATION: MARKING SHALL BE LEGIBLE. C. THE SUPPLIER SHALL CONFORM TO THE QUALITY ASSURANCE PROVISIONS THE CASE FINISH SHALL HAVE NO PITS, FLAKING OR CHIPPING, AS CONTAINED IN ND 1015404, CLASS 2. LEADS SHALL BE FREE FROM KINKS AND NICKS AND SHALL COMPLY WITH THE SPECIFIED LEAD MATERIAL REQUIREMENT. GLASS IN UNITS SHALL BE CAPABLE OF MEETING THE QUALIFICATION REQUIREMENTS AS CONTAINED HEADER SHALL HAVE NO CRACKS, CHIPS OR BUBBLES. THIS TEST IN ND 1002048 UNLESS MODIFIED OR AMENDED BY SECTION 2 OF THIS SHALL BE PERFORMED ON A 100-PERCENT-OF-A-LOT BASIS. THIS \_8 DRAWING. TEST PERFORMED UNDER 10X MAGNIFICATION PACKAGING AND PACKING: UNIT PACKAGING AND PACKING SHALL BE IN ACCORDANCE WITH MIL-S-19491, LEVEL A IN BOTH INSTANCES. ACCEPTANCE AND INSPECTION: A. LOT: A LOT IS DEFINED AS A GROUP OF PARTS IN A SINGLE PROCURE-> 5 K MENT SELECTED FROM A SINGLE CONTINUOUS PRODUCTION RUN USING LIKE MATERIALS WHICH ARE CONTROLLED USING A PROCESS WHICH IS THE SAME FROM THE BEGINNING TO THE END OF THE RUN. INSPECTION CONDITIONS: UNLESS OTHERWISE SPECIFIED HEREIN ALL INSPECTIONS SHALL BE MADE AT AN AMBIENT TEMPERATURE OF PLUS 25 DEGREES CENTIGRADE PLUS OR MINUS 3 DEGREES CENTIGRADE. C. ELECTRICAL: 100% TESTING (1) UNITS SHALL BE SUBJECTED TO THE ELECTRICAL TESTS SPECIFIED IN ND 1002917. SEE NOTE 3.A.(I) 250 Ω MECHANICAL: (REFERENCE MIL-STD-750 AS MODIFIED HEREIN) .370 .335 DIA 250 Ω (1) LEAD FATIGUE (DESTRUCTIVE): LEADS SHALL BE CAPABLE OF WITH-STANDING THE FULLCHING LEAD BEND TEST. THE UNIT SHALL BE HELD IN A VERTICAL POSITION WITH A ONE-POUND WEIGHT SUSPENDED FROM THE LEAD UNDER TEST. TWO CYCLES OF BENDING SHALL BE PERFORMED. A CYCLE CONSISTING OF MOVING THE BODY OF THE \* SEE PAR 3.3.2 UNIT, WHILE IN THE SAME PLANE, 90 DEGREES FROM THE VERTICAL .20 IN ONE DIRECTION, THEN 180 DEGREES IN THE OPPOSITE DIRECTION AND BACK 90 DEGREES TO THE ORIGINAL POSITION. NO MECHANICAL DAMAGE SHALL BE EVIDENCED AFTER THE TEST. A SAMPLE OF 3 FIGURE ! L BASE SEAT UNITS PER LOT SHALL BE TESTED. (H) REPLACES REV G WITH CHANGES (2) LEAD TENSION: EACH LEAD SHALL BE CAPABLE OF WITHSTANDING AN AXIAL PULL OF 4 POUNDS MINIMUM FOR 30 SECONDS. NO MECHANICAL DAMAGE SHALL BE EVIDENCED AFTER THE TEST. A SAMPLE OF 3 **FIND** NOMENCLATURE OR UNITS PER LOT SHALL BE TESTED. PART OR DESCRIPTION IDENTIFYING NO. SHEET 2 SHEET (3) THE ABOVE MECHANICAL TEST TO BE PERFORMED ON ELECTRICAL REJECTS. LIST OF MATERIALS REVISION STATUS OF SHEETS MANNED SPACECRAFT CENTER UNLESS OTHERWISE SPECIFIED PROCURE ONLY FROM APPROVED SOURCES LISTED IN INSTRUMENTATION LAB DIMENSIONS ARE IN INCHES HOUSTON, TEXAS ND 1002034 FOR THIS DRAWING. TOLERANCES ON SEMICONDUCTOR DEVICE, DECIMALS FRACTIONS CHECKED Ruggen / Mainters INTEGRATED SENSE AMPLIFIER APPROVAL TY Warroll 27 Angles DO NOT SCALE THIS DRAWING APPROVAL ELL CHER 27 Ly 63 MATERIAL SPECIFICATION CONTROL DRAWING SEE NOTES NASA DRAWING NO. NASA APPROVAL JACK Burney HEAT TREATMENT 1006769 USED ON **NEXT ASSY** FINAL FINISH MIT APPROVAL & Wasel 8/28/60 SCALE NONE WT SHEET | OF 2 **APPLICATION** INCHES PHOTOGRAPHIC SCALE ONLY

00085 REVISIONS 6949001 DATE APPROVAL DESCRIPTION MENT THEREBY INCURS NO RESPONSIBILITY NOR ANY OBLIGATION WHATSOEVER; MENT THEREBY INCURS NO RESPONSIBILITY NOR ANY OBLIGATION WHATSOEVER; AND THE FACT THAT THE GOVERNMENT MAY HAVE FORMULATED, FURNISHED, OR IN ANY WAY SUPPLIED THE SAID DRAWINGS, SPECIFICATIONS OR OTHER D \TA IS NOT TO BE REGARDED BY IMPLICATION OR OTHERWISE AS IN ANY MANNER LICENSING THE HOLDER OR ANY OTHER PERSON OR CORPORATION, OR CONVEYING ANY RIGHTS OR PERMISSION TO MANUFACTURE, USE, OR SELL ANY PATENTED INVENTION THAT MAY IN ANY WAY BE RELATED THERETO. THIS SHEET ADDED AND UPGRADED TO 128/63 CLASS A RELEASE PER TDRR 02823 REQUIREMENTS (CONTINUED): B. THE MANUFACTURER SHALL RECORD THE FOLLOWING CHARACTERISTICS 3. DESIGN: PRIOR TO AND FOLLOWING HIGH TEMPERATURE STORAGE: GAIN (G). MECHANICAL REQUIREMENTS: VOLTAGE RATIO ( $V_R$ ), RESOLUTION (R) AND DIFFERENTIAL OFFSET ( $V_\Omega$ ). (1) LEAD MATERIAL SHALL BE IRON-NICKEL-COBALT ALLOY (KOVAR) PARAMETRIC CHANGE LIMITS: IN ACCORDANCE WITH NASA DOCUMENT PS 1015402 EXCEPT LEAD (1) GAIN (G): PLUS OR MINUS 5 PERCENT. DIAMETER SHALL BE AS FOLLOWS: THE LEAD DIAMETER IN THE ZONE BETWEEN .050 AND .250 FROM THE BASE SEAT SHALL BE .016 (2) VOLTAGE RATIO (VR): PLUS OR MINUS 5 PERCENT. PLUS .003 MINUS .000. IN THE ZONE BETWEEN .250 AND 1.5 FROM (3) RESOLUTION (R): PLUS OR MINUS 10 PERCENT. THE BASE SEAT SHALL BE .021 MAXIMUM, AND OF THE REMAINDER (4) DIFFERENTIAL OFFSET (VO): PLUS OR MINUS 5 PERCENT. OF THE LEAD SHALL BE UNCONTROLLED. A CERTIFICATE OF COM-PLIANCE WITH THE LEAD MATERIAL REQUIREMENT SHALL ACCOMPANY D. UNITS WHICH FAIL TO MEET ALL INITIAL REQUIREMENTS OR WHICH EXCEED THE SPECIFIED LIMITS FOR PARAMETRIC CHANGES FOLLOWING EACH SHIPMENT. HIGH TEMPERATURE STORAGE SHALL NOT BE SHIPPED. (2) MARKING: (a) UNITS SHALL BE MARKED IN ACCORDANCE WITH MIL-STD-130 WITH THE MANUFACTURER'S IDENTIFICATION, DATE CODE, SERIAL NUMBER AND THE NUMBER 769. PLUS THE REVISION LETTER (b) INTERIOR AND EXTERIOR SHIPPING CONTAINERS SHALL BE MARKED IN ACCORDANCE WITH MIL-STD-129 WITH THE MANU-FACTURER'S NAME, LOT OR SERIAL NUMBER, DATE OF MANU-FACTURE OR CODING AND THE NASA DRAWING NUMBER AND REVISION LETTER. A TAG MARKED WITH THE FOREGOING INFORMATION SHALL BE INCLUDED IN EACH CONTAINER. (3) ENCLOSURE: METAL CASE WITH GLASS HEADER, HERMETICALLY SEALED (REFERENCE JEDEC TO-5 CASE). (4) SEMICONDUCTOR MATERIAL: SILICON, NPN, DIFFUSED OXIDE PASS-IVATED SURFACE. (5) INTERCONNECTIONS: THE DIFFUSED TRANSISTORS AND RESISTORS SHALL BE INTERCONNECTED AS SHOWN IN FIGURE 1. THE TRANSISTORS SHALL BE SEPARATED FROM EACH OTHER AND FROM RESISTORS BY DIFFUSED ISOLATION REGIONS. ELECTRICAL CHARACTERISTICS: (1) THE ELECTRICAL CHARACTERISTICS SHALL BE AS SPECIFIED IN SENSE AMPLIFIER ACCEPTANCE TEST PROCEDURE ND 1002017. (2) THE FOULVALENT CIRCUIT IS SHOWN IN FIG. 1. THE RESISTOR VALUES SHALL BE ±30%. RESISTOR R3 AND R4 SHALL BE GREATER THAN 20 OHMS. C. ABSOLUTE MAXIMUM RATINGS: (1) POWER DISSIPATION: 75 MILLIWATTS MAXIMUM WHILE OPERATING IN THE TEST CIRCUIT OF DAILBOAR AND TO SEE ND 1002017. (2) STORAGE TEMPERATURE: MINUS 65 DEGREES CENTIGRADE TO PLUS 200 DEGREES CENTIGRADE. (3) OPERATING TEMPERATURE: MINUS 20 DEGREES CENTIGRADE TO PLUS 125 DEGREES CENTIGRADE. (4) THERMAL IMPEDANCE, JUNCTION TO CASE: .. . . . . . . . . . . DEGREE CENTIGRADE (H) THIS SHEET ADDED PER MILLIWATT. (5) VOLTAGES: +20 VOLTS BETWEEN PIN 10 AND PIN 3. SPECIAL CONDITION 11.3. NOMENCLATURE OR PART OR DESCRIPTION IDENTIFYING NO. A. HIGH TEMPERATURE STORAGE: ALL UNITS SHALL BE STORED FOR 250 HOURS LIST OF MATERIALS AT 150 DEGREES CENTIGRADE MIN UNLESS OTHERWISE SPECIFIED MANNED SPACECRAFT CENTER INSTRUMENTATION LAB DIMENSIONS ARE IN INCHES HOUSTON, TEXAS TOLERANCES ON DECIMALS FRACTIONS SEMICONDUCTOR DEVICE, INTEGRATED SENSE AMPLIFIER APPROVAL EL Nascal 27 Ang 63 DO NOT SCALE THIS DRAWING APPROVAL ELLaCHELL 27 Aug 63 SPECIFICATION CONTROL DRAWING NASA DRAWING NO. HEAT TREATMENT NASA APPROVAL LECEB MANAGE 1006769 **NEXT ASSY** USED ON FINAL FINISH MIT APPROVAL & SCALE NONE WT SHEET 2 OF 2 APPLICATION

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